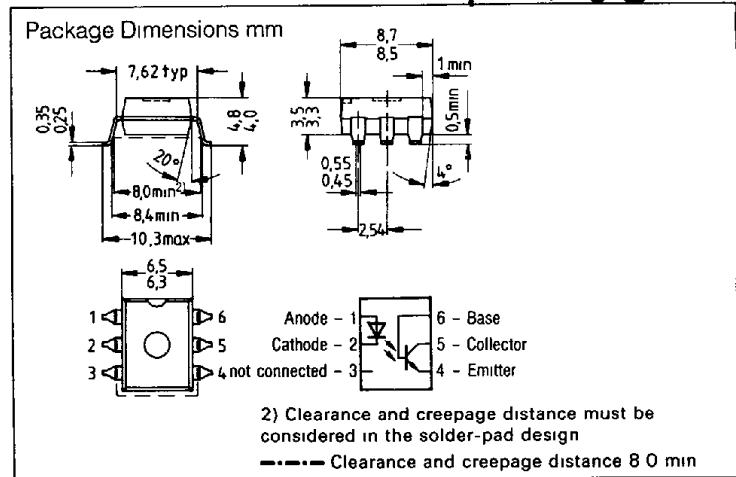
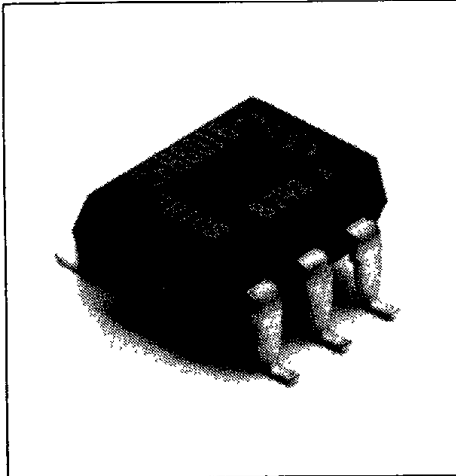


**SIEMENS****SFH 6016****5.3 kV TRIOS® OPTOCOUPLER  
HIGH RELIABILITY****FEATURES**

- Isolation Test Voltage: 5300 V
- High Current Transfer Ratios  
at 10 mA: 40-320%  
at 1 mA: 13-90%
- Fast Switching Times
- Minor CTR Degradation
- 100% Burn-In
- Field-Effect Stable by TRIOS
- Temperature Stable
- Good CTR Linearity Depending on Forward Current
- High Collector-Emitter Voltage  
 $V_{CE0} = 70\text{ V}$
- Low Saturation Voltage
- Low Coupling Capacitance
- External Base Wiring Possible
- UL Approval #52744
-  VDE Approval 0883
-  VDE Approval 0884 (Optional with Option 1)
- Conforms to VDE #0805/0806

**DESCRIPTION**

The optically coupled isolator SFH 6016 features a high current transfer ratio as well as a high isolation voltage. As emitter it employs a GaAs infrared emitting diode which is optically coupled with a silicon planar phototransistor acting as detector.

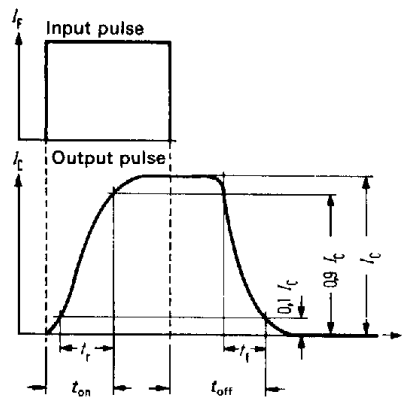
The component is incorporated in a plastic plug-in DIP-6 package.

The bent terminal pins are suitable for surface mounting (SMD). The electrical data complies with that of the SFH 601 coupler.

The coupler allows to transfer signals between two electrically isolated circuits. The potential difference between the circuits to be coupled is not allowed to exceed the maximum permissible reference voltages.

\*Transparent IO Shield

**Switching times**



The figure on the left defines the following times:

**Turn-on time ( $t_{ON}$ )**

The turn-on time  $t_{ON}$  is the time in which the output current (collector current)  $I_C$  rises to 90% of its maximum value after activation of the drive current  $I_F$ .

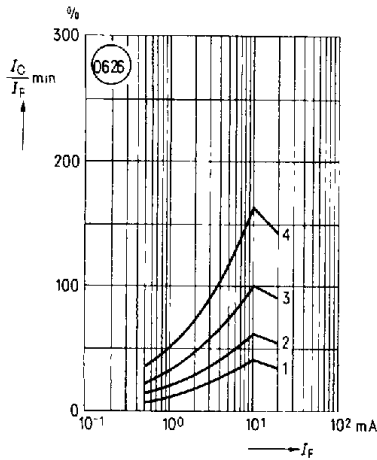
The rise time  $t_r$  is the time in which the collector current  $I_C$  rises from 10% to 90% of its final value

**Turn-off time ( $t_{OFF}$ )**

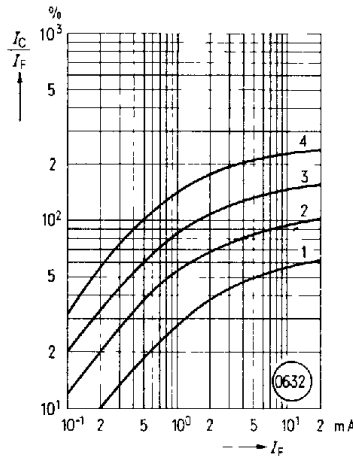
The turn-off time  $t_{OFF}$  is the time in which the collector current  $I_C$  drops to 10% of its maximum value after deactivation of the drive current  $I_F$ .

The fall time  $t_f$  is the time in which the collector current  $I_C$  drops from 90% to 10% of its maximum value.

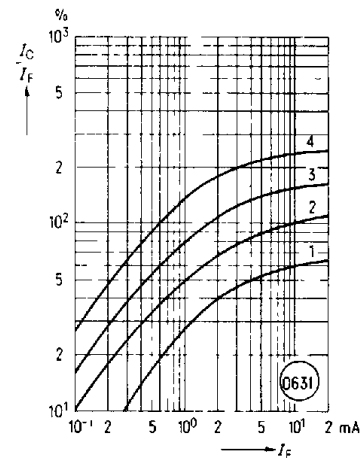
**Minimum current transfer ratio versus diode forward current**  
( $T_A=25^\circ\text{C}$ ,  $V_{CE}=5\text{ V}$ )



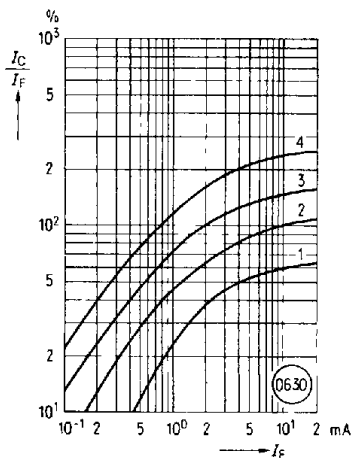
**Current transfer ratio (typ.) versus diode forward current**  
( $T_A=25^\circ\text{C}$ ,  $V_{CE}=5\text{ V}$ )



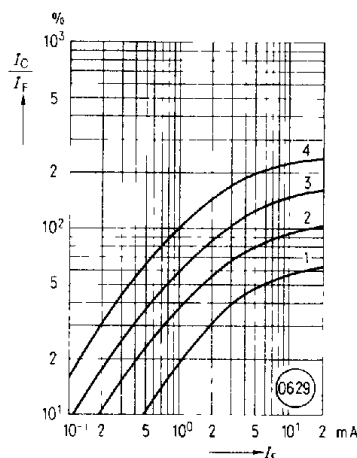
**Current transfer ratio (typ.) versus diode forward current**  
( $T_A=0^\circ\text{C}$ ,  $V_{CE}=5\text{ V}$ )



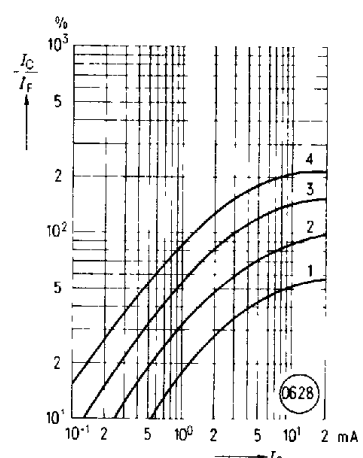
**Current transfer ratio (typ.) versus diode forward current**  
( $T_A=25^\circ\text{C}$ ,  $V_{CE}=5\text{ V}$ )



**Current transfer ratio (typ.) versus diode forward current**  
( $T_A=50^\circ\text{C}$ ,  $V_{CE}=5\text{ V}$ )



**Current transfer ratio (typ.) versus diode forward current**  
( $T_A=75^\circ\text{C}$ ,  $V_{CE}=5\text{ V}$ )



Optocouplers  
(Optoisolators)

**Maximum Ratings**

**Emitter** (GaAs Infrared Emitter)

Reverse Voltage	6 V
DC Forward Current	60 mA
Surge Forward Current ( $t \leq 10 \mu s$ )	2.5 A
Total Power Dissipation	100 mW

**Detector** (Silicon Phototransistor)

Collector-Emitter Voltage	70 V
Emitter-Base Voltage	7 V
Collector Current	50 mA
Collector Current ( $t \leq 1 ms$ )	100 mA
Total Power Dissipation	150 mW

**Optocoupler**

Storage Temperature Range	-40°C to +150°C
Ambient Temperature Range	-40°C to +100°C
Junction Temperature	100°C
Soldering Temperature (max. 10 s) <sup>1)</sup>	260°C
Isolation Test Voltage <sup>2)</sup>	

(between emitter and detector referred to standard climate 23/50 DIN 50014)	5300 VDC
Leakage Path	$\geq 8 mm$
Air path	$\geq 80 mm$

**Tracking Resistance**

In Accordance with VDE 0110 §6, table 3, and DIN 53480/VDE 0303, part 1	$\geq 100$ (group 3)
Isolation Resistance ( $V_{io}=500 V$ )	$10^{11} \Omega$

**Notes:**

- 1 Not for wave-soldering
- 2 DC test voltage in accordance with VDE 0883/6 80

**Characteristics ( $T_A=25^\circ C$ )**

**Emitter** (GaAs Infrared Emitter)

Forward Voltage ( $I_F=60 mA$ )	$V_F$	1.25 ( $\leq 1.65$ )	V
Breakdown Voltage ( $I_R=100 \mu A$ )	$V_{BR}$	30 ( $\geq 6$ )	V
Reverse Current ( $V_R=6 V$ )	$I_R$	0.01 ( $\leq 10$ )	$\mu A$
Capacitance ( $V_a=0 V, f=1 MHz$ )	$C_o$	40	pF
Thermal Resistance <sup>1)</sup>	$R_{THUA}$	750	K/W

**Detector** (Silicon Phototransistor)

Capacitance			
( $V_{CE}=5 V, f=1 MHz$ )	$C_{CE}$	6.8	pF
( $V_{CB}=5 V, f=1 MHz$ )	$C_{CB}$	8.5	pF
( $V_{EB}=5 V, f=1 MHz$ )	$C_{EB}$	11	pF
Thermal Resistance <sup>1)</sup>	$R_{THUA}$	500	K/W

**Optocoupler**

Collector-Emitter Saturation Voltage ( $I_F=10 mA, I_C=2.5 mA$ )	$V_{CESAT}$	0.25 ( $\leq 0.4$ )	V
Coupling Capacitance	$C_K$	0.55	pF

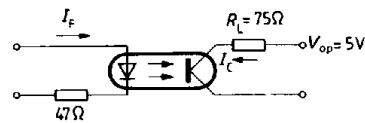
**Note:**

- 1 Static air, coupler soldered to PCB or base

The optocouplers are grouped according to their current transfer ratio  $I_C/I_F$  at  $V_{CE}=5 V$ , marked by dash numbers

	-1	-2	-3	-4	
$I_C/I_F$ ( $I_F=10 mA$ )	40-80	63-125	100-200	160-320	%
$I_C/I_F$ ( $I_F=1 mA$ )	30 (>13)	45 (>22)	70 (>34)	90 (>56)	%
Collector-Emitter Leakage Current ( $V_{CE}=10 V$ ) ( $I_{CE0}$ )	2 ( $\leq 50$ )	2 ( $\leq 50$ )	5 ( $\leq 100$ )	5 ( $\leq 100$ )	nA

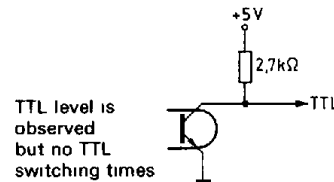
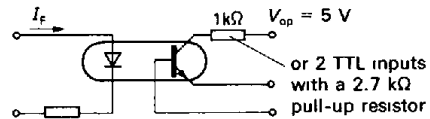
**Linear Operation** (without saturation)



$I_F=10 mA, V_{OP}=5 V, T_A=25^\circ C$

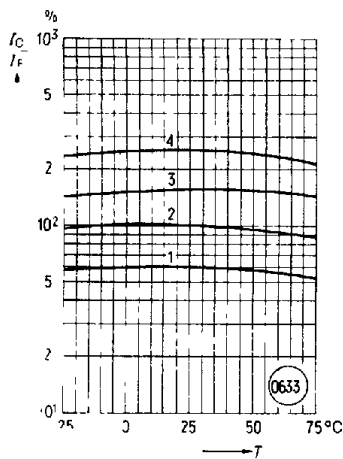
Load Resistance	$R_L$	75	$\Omega$
Turn-On Time	$t_{ON}$	3.0 ( $\leq 5.6$ )	$\mu s$
Rise Time	$t_r$	2.0 ( $\leq 4.0$ )	$\mu s$
Turn-Off Time	$t_{OFF}$	2.3 ( $\leq 4.1$ )	$\mu s$
Fall Time	$t_f$	2.0 ( $\leq 3.5$ )	$\mu s$
Cut-Off Frequency	$F_{CO}$	250	kHz

**Switching Operation** (with saturation)

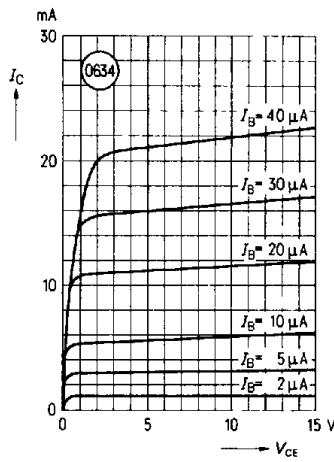


Group	-1 ( $I_F=20 mA$ )	-2 and -3 ( $I_F=10 mA$ )	-4 ( $I_F=5 mA$ )	
Turn-On Time $t_{ON}$	3.0 ( $\leq 5.5$ )	4.2 ( $\leq 8.0$ )	6.0 ( $\leq 10.5$ )	$\mu s$
Rise Time $t_r$	2.0 ( $\leq 4.0$ )	3.0 ( $\leq 6.0$ )	4.6 ( $\leq 8.0$ )	$\mu s$
Turn-Off Time $t_{OFF}$	18 ( $\leq 34$ )	23 ( $\leq 39$ )	25 ( $\leq 43$ )	$\mu s$
Fall Time $t_f$	11 ( $\leq 20$ )	14 ( $\leq 24$ )	15 ( $\leq 26$ )	$\mu s$
$V_{CESAT}$	0.25 ( $\leq 0.4$ )			V

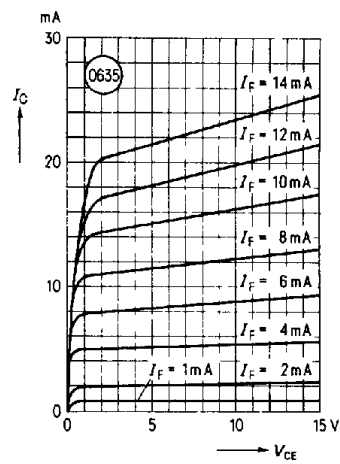
**Current transfer ratio (typ.) versus temperature**  
( $I_F = 10 \text{ mA}$ ,  $V_{CE} = 5 \text{ V}$ )



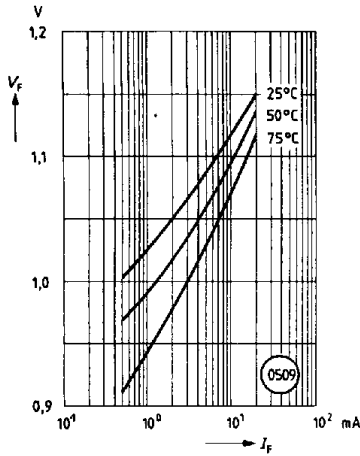
**Transistor characteristics**  
Collector current versus collector-emitter voltage  
(Current gain  $B = 550$ ,  $T_A = 25^\circ\text{C}$ ,  $I_F = 0$ )



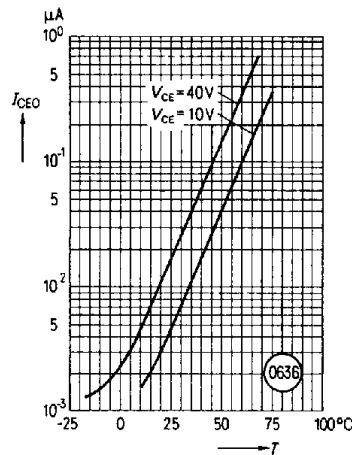
**Output characteristics (typ.)**  
Collector current versus collector-emitter voltage  
Base not connected ( $T_A = 25^\circ\text{C}$ )



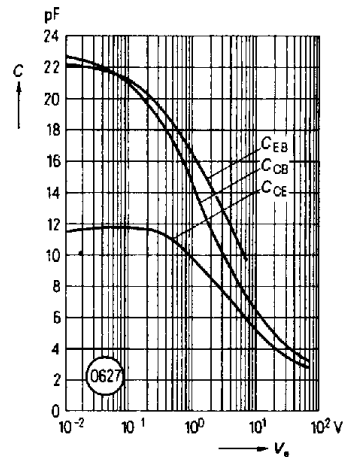
**Forward voltage (typ.) of the diode versus forward current**



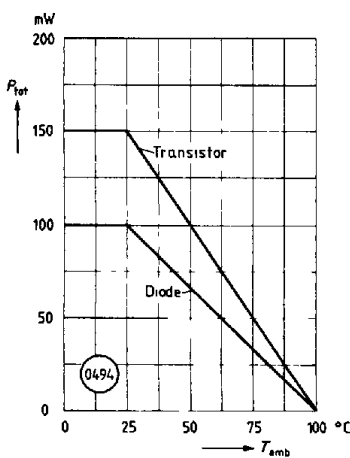
**Collector-emitter leakage current (typ.) of the transistor versus temperature**  
( $T_A = 25^\circ\text{C}$ ,  $I_F = 0$ )



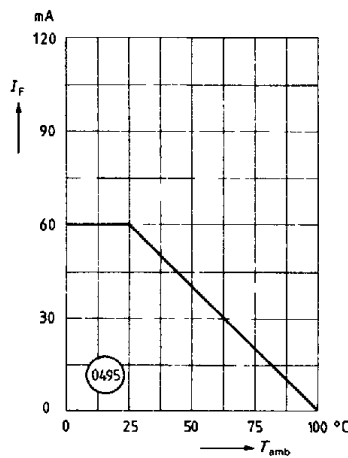
**Transistor capacitance (typ.) versus emitter voltage**  
( $T_A = 25^\circ\text{C}$ ,  $f = 1 \text{ MHz}$ )



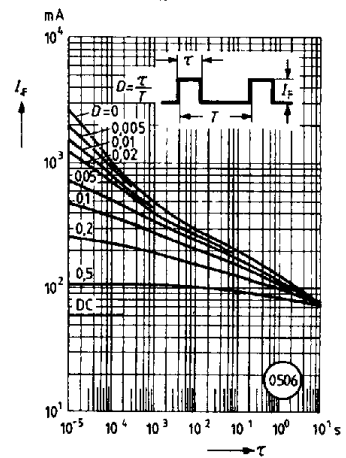
**Permissible power dissipation versus ambient temperature**



**Permissible forward current of the diode versus ambient temperature**

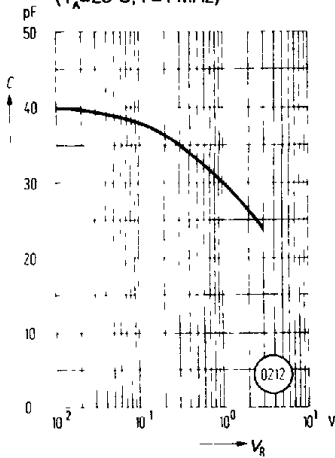


**Permissible pulse handling capability**  
Forward current versus pulse width  
( $D = \text{parameter}$ ,  $T_A = 25^\circ\text{C}$ )



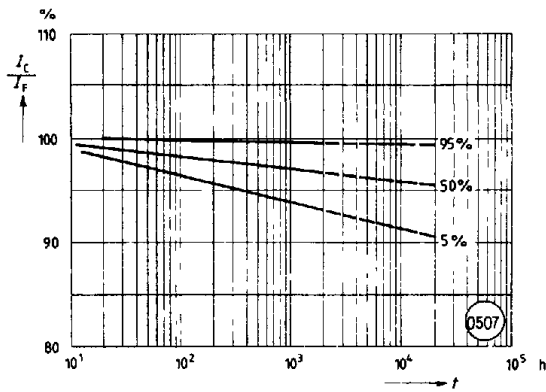
Optocouplers  
(Optoisolators)

**Diode capacitance (typ.) versus reverse voltage**  
( $T_A=25^\circ\text{C}$ ,  $f=1\text{ MHz}$ )

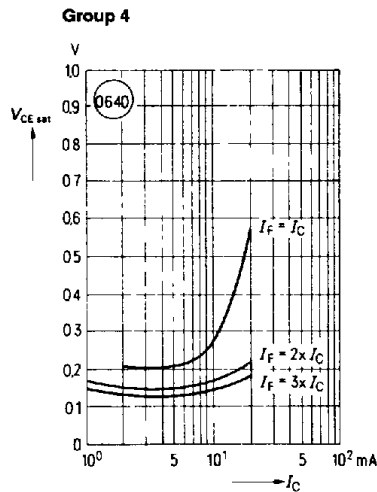
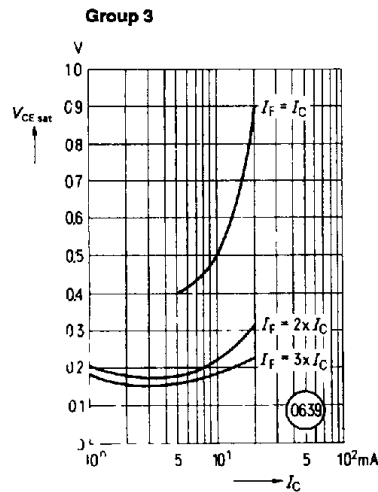
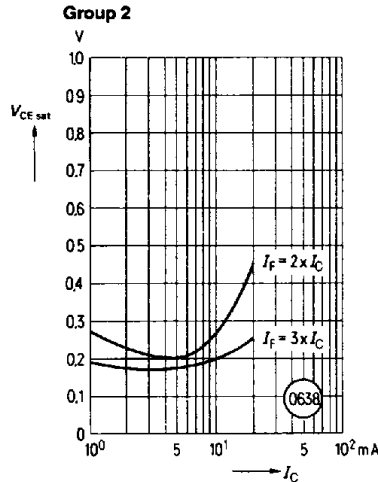
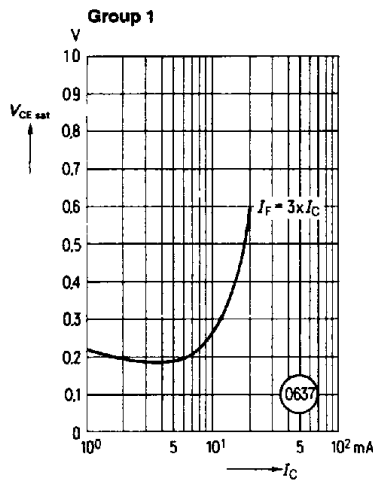


**Current transfer ratio versus load time**

( $V_{CE}=5\text{ V}$ ,  $R_L=1\text{ k}\Omega$ ,  $T_A=25^\circ\text{C}$ ,  $I_C=60\text{ mA}$ , Measuring current = 10 mA, Confidence coefficient  $S=60\%$ )



**Collector-emitter saturation voltage (typ.) versus collector current and control range<sup>1)</sup> for: ( $T_A=25^\circ\text{C}$ )**



**Note:**

1)  $I_F=2 \times I_C$  means that the current flow of the diode has to be adjusted to twice the value of the collector current